

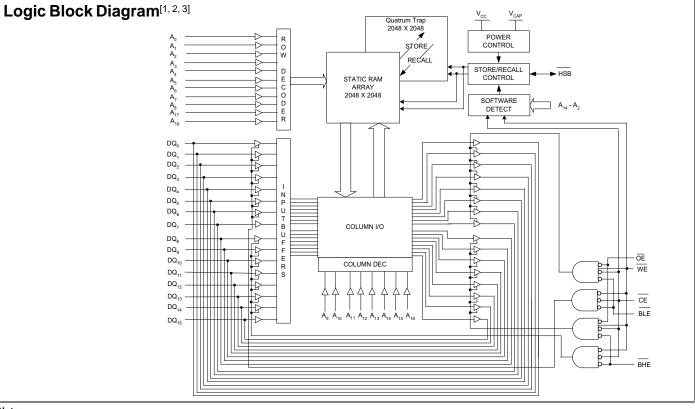
CY14B104LA, CY14B104NA 4 Mbit (512K x 8/256K x 16) nvSRAM

Features

- 20 ns, 25 ns, and 45 ns access times
- Internally organized as 512K x 8 (CY14B104LA) or 256K x 16 (CY14B104NA)
- Hands off automatic STORE on power down with only a small capacitor
- STORE to QuantumTrap[®] nonvolatile elements initiated by software, device pin, or AutoStore[®] on power down
- RECALL to SRAM initiated by software or power up
- Infinite Read, Write, and Recall cycles
- 200,000 STORE cycles to QuantumTrap
- 20 year data retention
- Single 3V +20%, -10% operation
- Commercial and industrial temperatures
- 48-ball FBGA and 44/54-pin TSOP-II packages
- Pb-free and RoHS compliance

Functional Description

The Cypress CY14B104LA/CY14B104NA is a fast static RAM, with a nonvolatile element in each memory cell. The memory is organized as 512K bytes of 8 bits each or 256K words of 16 bits each. The embedded nonvolatile elements incorporate QuantumTrap technology, producing the world's most reliable nonvolatile memory. The SRAM provides infinite read and write cycles, while independent nonvolatile data resides in the highly reliable QuantumTrap cell. Data transfers from the SRAM to the nonvolatile elements (the STORE operation) takes place automatically at power down. On power up, data is restored to the SRAM (the RECALL operation) from the nonvolatile memory. Both the STORE and RECALL operations are also available under software control.



Notes

- 1.
- Address A₀ A₁₈ for x8 configuration and Address A₀ A₁₇ for x16 configuration. <u>Data</u> $DQ_0 DQ_7$ for x8 configuration and Data $DQ_0 DQ_{15}$ for x16 configuration. 2

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3. BHE and BLE are applicable for x16 configuration only.

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Pinouts

Figure 1. Pin Diagram - 48 FBGA

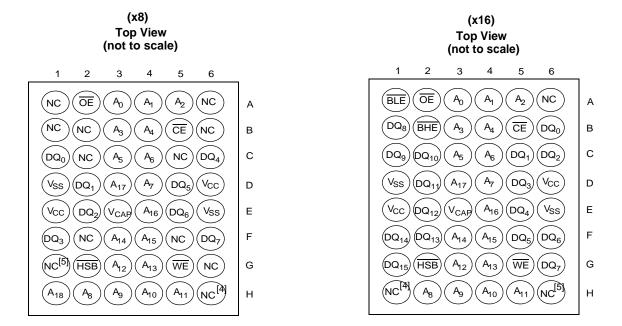
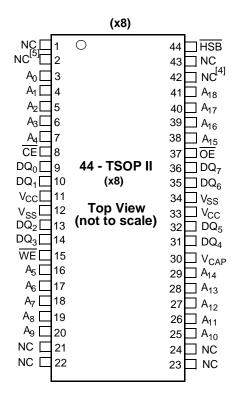
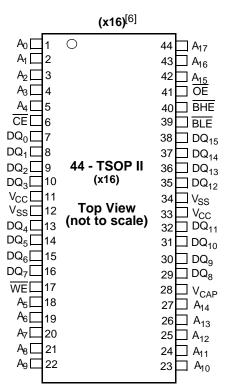


Figure 2. Pin Diagram - 44 Pin TSOP II





Notes

4. Address expansion for 8 Mbit. NC pin not connected to die.

Address expansion for 16 Mbit. NC pin not connected to die. HSB pin is not available in 44-TSOP II (x16) package. 5.

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Pinouts (continued)

Figure 3. Pin Diagram - 54 Pin TSOP II (x16)

$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	O 54 - TSOP II (x16) Top View (not to scale)	54 HSB 53 NC ^[4] 52 A ₁₇ 51 A ₁₆ 50 A ₁₅ 49 OE 48 BHE 47 BLE 46 DQ ₁₅ 45 DQ ₁₄ 44 DQ ₁₂ 42 Vss 41 Vccap 38 DQ9 37 DQ8 36 Vcap 35 A ₁₄ 34 A ₁₃ 32 A ₁₁ 31 A ₁₀ 30 NC 28 NC
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Pin Definitions

Pin Name	I/O Type	Description
A ₀ – A ₁₈	Input	Address Inputs Used to Select one of the 524,288 bytes of the nvSRAM for x8 Configuration.
$A_0 - A_{17}$		Address Inputs Used to Select one of the 262,144 words of the nvSRAM for x16 Configuration.
$DQ_0 - DQ_7$	Input/Output	Bidirectional Data I/O Lines for x8 Configuration. Used as input or output lines depending on operation.
DQ ₀ – DQ ₁₅		Bidirectional Data I/O Lines for x16 Configuration. Used as input or output lines depending on operation.
WE	Input	Write Enable Input, Active LOW. When selected LOW, data on the I/O pins is written to the specific address location.
CE	Input	Chip Enable Input, Active LOW. When LOW, selects the chip. When HIGH, deselects the chip.
OE	Input	Output Enable, Active LOW . The active LOW OE input enables the data output buffers during read cycles. I/O pins are tri-stated on deasserting OE HIGH.
BHE	Input	Byte High Enable, Active LOW. Controls DQ ₁₅ - DQ ₈ .
BLE	Input	Byte Low Enable, Active LOW. Controls DQ ₇ - DQ ₀ .
V _{SS}	Ground	Ground for the Device. Must be connected to the ground of the system.
V _{CC}	Power Supply	Power Supply Inputs to the Device.
HSB ^[6]	Input/Output	Hardware Store Busy (HSB). When LOW this output indicates that a hardware store is in progress. When pulled LOW external to the chip it initiates a nonvolatile STORE operation. A weak internal pull up resistor keeps this pin HIGH if not connected (connection optional). After each store operation HSB is driven HIGH for short time with standard output high current.
V _{CAP}	Power Supply	AutoStore Capacitor. Supplies power to the nvSRAM during power loss to store data from SRAM to nonvolatile elements.
NC	No Connect	No Connect. This pin is not connected to the die.



Device Operation

The CY14B104LA/CY14B104NA nvSRAM is made up of two functional components paired in the same physical cell. They are a SRAM memory cell and a nonvolatile QuantumTrap cell. The SRAM memory cell operates as a standard fast static RAM. Data in the SRAM is transferred to the nonvolatile cell (the STORE operation), or from the nonvolatile cell to the SRAM (the RECALL operation). Using this unique architecture, all cells are stored and recalled in parallel. During the STORE and RECALL operations, SRAM read and write operations are inhibited. The CY14B104LA/CY14B104NA supports infinite reads and writes similar to a typical SRAM. In addition, it provides infinite RECALL operations. See the Truth Table For SRAM Operations on page 16 for a complete description of read and write modes.

SRAM Read

<u>The CY14B104LA/CY14B104NA performs a read cycle when</u> CE and OE are LOW and WE and HSB are HIGH. The address specified on pins A_{0-18} or A_{0-17} determines which of the 524,288 data bytes or 262,144 words of 16 bits each are accessed. Byte enables (BHE, BLE) determine which bytes are enabled to the output, in the case of 16-bit words. When the read is initiated by an address transition, the outputs are valid after a delay of t_{AA} (read cycle 1). If the read is initiated by CE or OE, the outputs are valid at t_{ACE} or at t_{DOE} , whichever is later (read cycle 2). The data output repeatedly responds to address changes within the t_{AA} access time without the need for transitions on any control input_pins. This remains valid until another address change or until CE or OE is brought HIGH, or WE or HSB is brought LOW.

SRAM Write

A write cycle is performed when CE and WE are LOW and HSB is HIGH. The address inputs must be stable before entering the write cycle and must remain stable until CE or WE goes HIGH at the end of the cycle. The data on the common I/O pins DQ_{0-15} are written into the memory if the data is valid t_{SD} before the end of a WE controlled write or before the end of an CE controlled write. The Byte Enable inputs (BHE, BLE) determine which bytes are written, in the case of 16-bit words. It is recommended that OE be kept HIGH during the entire write cycle to avoid data bus contention on common I/O lines. If OE is left LOW, internal circuitry turns off the output buffers t_{HZWE} after WE goes LOW.

AutoStore Operation

The CY14B104LA/CY14B104NA stores data to the nvSRAM using one of the <u>following</u> three storage operations: Hardware Store activated by HSB; Software Store activated by an address sequence; AutoStore on device power down. The AutoStore operation is a unique feature of QuantumTrap technology and is enabled by default on the CY14B104LA/CY14B104NA.

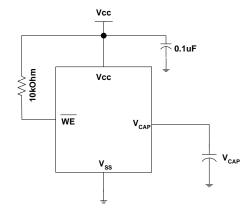
During a normal operation, the device draws current from V_{CC} to charge a capacitor connected to the V_{CAP} pin. This stored charge is used by the chip to perform a single STORE operation. If the voltage on the V_{CC} pin drops below V_{SWITCH}, the part automatically disconnects the V_{CAP} pin from V_{CC}. A STORE operation is initiated with power provided by the V_{CAP} capacitor.

Figure 4 shows the proper connection of the storage capacitor (V_{CAP}) for automatic store operation. Refer to DC Electrical

Characteristics on page 8 for the size of V_{CAP}. The voltage on the V_{CAP} pin is driven to V_{CC} by a regulator on the chip. A pull up should be placed on WE to hold it inactive during power up. This pull up is effective only if the WE signal is tri-state during power up. Many MPUs tri-state their controls on power up. This should be verified when using the pull up. When the nvSRAM comes out of power-on-recall, the MPU must be active or the WE held inactive until the MPU comes out of reset.

To reduce unnecessary nonvolatile stores, AutoStore and hardware store operations are ignored unless at least one write operation has taken place since the most recent STORE or RECALL cycle. Software initiated STORE cycles are performed regardless of whether a write operation has taken place. The HSB signal is monitored by the system to detect if an AutoStore cycle is in progress.

Figure 4. AutoStore Mode



Hardware STORE Operation

The CY14B104LA/CY14B104NA provides the $\overline{\text{HSB}}^{[6]}$ pin to control and acknowledge the STORE operations. Use the HSB pin to request a hardware STORE cycle. When the HSB pin is driven LOW, the CY14B104LA/CY14B104NA conditionally initiates a STORE operation after t_{DELAY}. An actual STORE cycle only begins if a write to the SRAM has taken place since the last STORE or RECALL cycle. The HSB pin also acts as an open drain driver that is internally driven LOW to indicate a busy condition when the STORE (initiated by any means) is in progress.

SRAM read and write operations that are in progress when HSB is driven LOW by any means are given time to complete before the STORE operation is initiated. After HSB goes LOW, the CY14B104LA/CY14B104NA continues SRAM operations for t_{DELAY} . If a write is in progress when HSB is pulled LOW it is enabled a time, t_{DELAY} to complete. However, any SRAM write cycles requested after HSB goes LOW are inhibited until HSB returns HIGH. In case the write latch is not set, HSB is not driven LOW by the CY14B104LA/CY14B104LA/CY14B104LA/CY14B104NA. But any SRAM read and write cycles are inhibited until HSB is returned HIGH by MPU or other external source.

During any STORE operation, regardless of how it is initiated, the CY14B104LA/CY14B104NA continues to drive the HSB pin LOW, releasing it only when the STORE is complete. When the STORE operation is completed, the CY14B104LA/CY14B104NA



remains disabled until the $\overline{\text{HSB}}$ pin returns HIGH. Leave the $\overline{\text{HSB}}$ unconnected if it is not used.

Hardware RECALL (Power Up)

During power up or after any low power condition $(V_{CC} < V_{SWITCH})$, an internal RECALL request is latched. When V_{CC} again exceeds the sense voltage of V_{SWITCH} , a RECALL cycle is automatically initiated and takes $t_{HRECALL}$ to complete. During this time, HSB is driven LOW by the HSB driver.

Software STORE

Transfer data from the SRAM to the nonvolatile memory with a software address sequence. The CY14B104LA/CY14B104<u>NA</u> software STORE cycle is initiated by executing sequential \overline{CE} controlled read cycles from six specific address locations in exact order. During the STORE cycle an erase of the previous nonvolatile data is first performed, followed by a program of the nonvolatile elements. After a STORE cycle is initiated, further input and output are disabled until the cycle is completed.

Because a sequence of READs from specific addresses is used for STORE initiation, it is important that no other read or write accesses intervene in the sequence, or the sequence is aborted and no STORE or RECALL takes place.

To initiate the software STORE cycle, the following read sequence must be performed.

- 1. Read Address 0x4E38 Valid READ
- 2. Read Address 0xB1C7 Valid READ
- 3. Read Address 0x83E0 Valid READ
- 4. Read Address 0x7C1F Valid READ
- 5. Read Address 0x703F Valid READ
- 6. Read Address 0x8FC0 Initiate STORE Cycle

Table 1. Mode Selection

The software sequence may be clocked with $\overline{\text{CE}}$ controlled reads or $\overline{\text{OE}}$ controlled reads. After the sixth address in the sequence is entered, the STORE cycle commences and the chip is disabled. HSB is driven LOW. It is important to use read cycles and <u>not</u> write cycles in the sequence, although it is not necessary that $\overline{\text{OE}}$ be LOW for a valid sequence. After the t_{STORE} cycle time is fulfilled, the SRAM is activated again for the read and write operation.

Software RECALL

Transfer the data from the nonvolatile memory to the SRAM with a software address sequence. A software RECALL cycle is initiated with a sequence of read operations in a manner similar to the software STORE initiation. To initiate the RECALL cycle, the following sequence of CE controlled read operations must be performed.

- 1. Read Address 0x4E38 Valid READ
- 2. Read Address 0xB1C7 Valid READ
- 3. Read Address 0x83E0 Valid READ
- 4. Read Address 0x7C1F Valid READ
- 5. Read Address 0x703F Valid READ
- 6. Read Address 0x4C63 Initiate RECALL Cycle

Internally, RECALL is a two step procedure. First, the SRAM data is cleared; then, the nonvolatile information is transferred into the SRAM cells. After the t_{RECALL} cycle time, the SRAM is again ready for read and write operations. The RECALL operation does not alter the data in the nonvolatile elements.

CE	WE	OE, BHE, BLE ^[3]	A ₁₅ - A ₀ ^[7]	Mode	I/O	Power
Н	Х	Х	Х	Not Selected	Output High Z	Standby
L	Н	L	Х	Read SRAM	Output Data	Active
L	L	Х	Х	Write SRAM	Input Data	Active
L	н	L	0x4E38 0xB1C7 0x83E0 0x7C1F 0x703F 0x8B45	Read SRAM Read SRAM Read SRAM Read SRAM Read SRAM AutoStore Disable	Output Data Output Data Output Data Output Data Output Data Output Data	Active ^[8]

Notes

- 7. While there are 19 address lines on the CY14B104LA (18 address lines on the CY14B104NA), only the 13 address lines (A14 A2) are used to control software modes.
- Rest of the address lines are don't care.
 8. The six consecutive address locations must be in the order listed. WE must be HIGH during all six cycles to enable a nonvolatile cycle.





Table 1. Mode Selection (continued)

CE	WE	OE, BHE, BLE ^[3]	A ₁₅ - A ₀ ^[7]	Mode	I/O	Power
L	Н	L	0x4E38 0xB1C7 0x83E0 0x7C1F 0x703F 0x4B46	Read SRAM Read SRAM Read SRAM Read SRAM Read SRAM AutoStore Enable	Output Data Output Data Output Data Output Data Output Data Output Data	Active ^[8]
L	Н	L	0x4E38 0xB1C7 0x83E0 0x7C1F 0x703F 0x8FC0	Read SRAM Read SRAM Read SRAM Read SRAM Read SRAM Nonvolatile Store	Output Data Output Data Output Data Output Data Output Data Output High Z	Active I _{CC2^[8]}
L	Н	L	0x4E38 0xB1C7 0x83E0 0x7C1F 0x703F 0x4C63	Read SRAM Read SRAM Read SRAM Read SRAM Read SRAM Nonvolatile Recall	Output Data Output Data Output Data Output Data Output Data Output High Z	Active ^[8]

Preventing AutoStore

The AutoStore function is disabled by initiating an AutoStore disable sequence. A sequence of read operations is performed in a manner similar to the software STORE initiation. To initiate the AutoStore disable sequence, the following sequence of CE controlled read operations must be performed:

- 1. Read address 0x4E38 Valid READ
- 2. Read address 0xB1C7 Valid READ
- 3. Read address 0x83E0 Valid READ
- 4. Read address 0x7C1F Valid READ
- 5. Read address 0x703F Valid READ
- 6. Read address 0x8B45 AutoStore Disable

The AutoStore is re-enabled by initiating an AutoStore enable sequence. A sequence of read operations is performed in a manner similar to the software RECALL initiation. To initiate the AutoStore enable sequence, the following sequence of CE controlled read operations must be performed:

- 1. Read address 0x4E38 Valid READ
- 2. Read address 0xB1C7 Valid READ
- Read address 0x83E0 Valid READ
- 4. Read address 0x7C1F Valid READ
- 5. Read address 0x703F Valid READ
- 6. Read address 0x4B46 AutoStore Enable

If the AutoStore function is disabled or re-enabled, a manual STORE operation (hardware or software) must be issued to save the AutoStore state through subsequent power down cycles. The part comes from the factory with AutoStore enabled.

Data Protection

The CY14B104LA/CY14B104NA protects data from corruption during low voltage conditions by inhibiting all externally initiated STORE and write operations. The low voltage condition is detected when V_{CC} < V_{SWITCH} . If the CY14B104LA/CY14B104NA is in a write mode (both CE and WE are LOW) at power up, after a RECALL or STORE, the write is inhibited until the SRAM is enabled after t_{LZHSB} (HSB to output active). This protects against inadvertent writes during power up or brown out conditions.

Noise Considerations

Refer to CY application note AN1064.



Best Practices

nvSRAM products have been used effectively for over 15 years. While ease-of-use is one of the product's main system values, experience gained working with hundreds of applications has resulted in the following suggestions as best practices:

- The nonvolatile cells in this nvSRAM product are delivered from Cypress with 0x00 written in all cells. Incoming inspection routines at customer or contract manufacturer's sites sometimes reprogram these values. Final NV patterns are typically repeating patterns of AA, 55, 00, FF, A5, or 5A. End product's firmware should not assume an NV array is in a set programmed state. Routines that check memory content values to determine first time system configuration, cold or warm boot status, and so on should always program a unique NV pattern (that is, complex 4-byte pattern of 46 E6 49 53 hex or more random bytes) as part of the final system manufacturing test to ensure these system routines work consistently.
- Power up boot firmware routines should rewrite the nvSRAM into the desired state (for example, autostore enabled). While the nvSRAM is shipped in a preset state, best practice is to again rewrite the nvSRAM into the desired state as a safeguard against events that might flip the bit inadvertently such as program bugs and incoming inspection routines.
- The VCAP value specified in this data sheet includes a minimum and a maximum value size. Best practice is to meet this requirement and not exceed the maximum VCAP value because the nvSRAM internal algorithm calculates VCAP charge and discharge time based on this max V_{CAP} value. Customers that want to use a larger VCAP value to make sure there is extra store charge and store time should discuss their VCAP size selection with Cypress to understand any impact on the VCAP voltage level at the end of a t_{RECALL} period.



Maximum Ratings

Exceeding maximum ratings may impair the useful life of the device. These user guidelines are not tested.

Transient Voltage (<20 ns) on Any Pin to Ground Potential
Package Power Dissipation Capability ($T_A = 25^{\circ}C$)1.0W
Surface Mount Pb Soldering Temperature (3 Seconds)+260°C
DC Output Current (1 output at a time, 1s duration)15 mA
Static Discharge Voltage
Latch Up Current > 200 mA

Operating Range

Range	Ambient Temperature	V _{CC}
Commercial	0°C to +70°C	2.7V to 3.6V
Industrial	–40°C to +85°C	2.7V to 3.6V

DC Electrical Characteristics Over the Operating Range ($V_{CC} = 2.7V$ to 3.6V)

Parameter	Description	Test Conditions		Min	Max	Unit
I _{CC1}	Average V _{CC} Current	t _{RC} = 20 ns t _{RC} = 25 ns t _{RC} = 45 ns	Commercial		65 65 50	mA mA mA
		Values obtained without output loads (I _{OUT} = 0 mA)	Industrial		70 70 52	mA mA mA
I _{CC2}	Average V _{CC} Current during STORE	All Inputs Don't Care, V _{CC} = Max Average current for duration t _{STORE}			10	mA
I _{CC3} ^[9]	Average V _{CC} Current at t _{RC} = 200 ns, 3V, 25°C typical	All I/P cycling at CMOS levels. Values obtained without output loads (I _{OUT} = 0 mA).			35	mA
I _{CC4}	Average V _{CAP} Current during AutoStore Cycle	All Inputs Don't Care, V _{CC} = Max Average current for duration t _{STORE}			5	mA
I _{SB}	V _{CC} Standby Current	$\overline{CE} \ge (V_{CC} - 0.2V)$. All others $V_{IN} \le 0.2V$ or $\ge (V_{CC} - 0.2V)$. Standby current level after nonvolatile cycle is complete. Inputs are static. f = 0 MHz.			5	mA
I _{IX} ^[10]	Input Le <u>aka</u> ge Current (except HSB)	$V_{CC} = Max, V_{SS} \le V_{IN} \le V_{CC}$		-1	+1	μA
	Inpu <u>t Lea</u> kage Current (for HSB)	$V_{CC} = Max, V_{SS} \le V_{IN} \le V_{CC}$		-100	+1	μA
I _{OZ}	Off-State Output Leakage Current	$V_{CC} = Max, V_{SS} \le V_{OUT} \le V_{CC}, \overline{CE} \text{ or } \overline{OE} \ge V_{IH} \text{ or } \overline{BHE}/\overline{BLE} \ge V_{IH}$ or $WE \le V_{II}$		-1	+1	μA
V _{IH}	Input HIGH Voltage			2.0	V _{CC} + 0.5	V
V _{IL}	Input LOW Voltage			$V_{ss} - 0.5$	0.8	V
V _{OH}	Output HIGH Voltage	I _{OUT} = -2 mA		2.4		V
V _{OL}	Output LOW Voltage	I _{OUT} = 4 mA			0.4	V
V _{CAP} ^[11]	Storage Capacitor	Between V _{CAP} pin and V _{SS} , 5V Rated		61	180	μF

Notes

Typical conditions for the active current shown on the DC Electrical characteristics are average values at 25°C (room temperature), and V_{CC} = 3V. Not 100% tested.
 The HSB pin has I_{OUT} = -2 uA for V_{OH} of 2.4V when both active HIGH and LOW drivers are disabled. When they are enabled standard V_{OH} and V_{OL} are valid. This parameter is characterized but not tested.
 V_{CAP} (storage capacitor) nominal value is 68 uF.



Data Retention and Endurance

Parameter	Description	Min	Unit
DATA _R	Data Retention	20	Years
NV _C	Nonvolatile STORE Operation	200	K

Capacitance

In the following table, the capacitance parameters are listed.^[12]

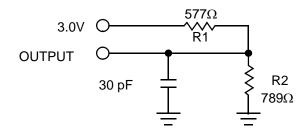
Parameter	Description	Test Conditions	Max	Unit
C _{IN}	Input Capacitance	$T_A = 25^{\circ}C, f = 1 \text{ MHz},$	7	pF
C _{OUT}	Output Capacitance	$V_{CC} = 0$ to 3.0V	7	pF

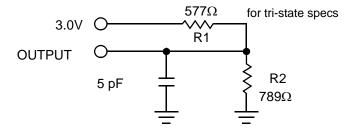
Thermal Resistance

In the following table, the thermal resistance parameters are listed. ^[12]

Parame	eter Description	Test Conditions	48-FBGA	44-TSOP II	54-TSOP II	Unit
Θ_{JA}		Test conditions follow standard test methods and procedures for measuring thermal	28.82	31.11	30.73	°C/W
Θ^{JC}	Thermal Resistance (Junction to Case)	impedance, in accordance with EIA/JESD51.	7.84	5.56	6.08	°C/W

Figure 5. AC Test Loads





AC Test Conditions

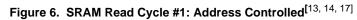
Input Pulse Levels	OV to 3V
Input Rise and Fall Times (10% - 90%)	<u><</u> 3 ns
Input and Output Timing Reference Levels	1.5V

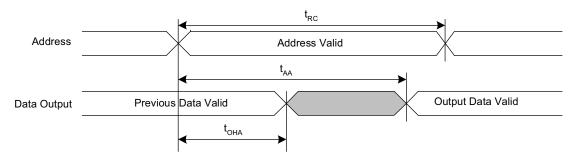


AC Switching Characteristics

Param	neters		20	ns	25 ns		45 ns		
Cypress Parameters	Alt Parameters	Description	Min	Max	Min	Max	Min	Max	Unit
SRAM Read Cyc	cle	· · ·					•		
t _{ACE}	t _{ACS}	Chip Enable Access Time		20		25		45	ns
t _{RC} ^[13]	t _{RC}	Read Cycle Time	20		25		45		ns
t _{AA} [14]	t _{AA}	Address Access Time		20		25		45	ns
t _{DOE}	t _{OE}	Output Enable to Data Valid		10		12		20	ns
t _{OHA} ^[14]	t _{OH}	Output Hold After Address Change	3		3		3		ns
t _{LZCE} [12, 15]	t _{LZ}	Chip Enable to Output Active	3		3		3		ns
t _{HZCE} [12, 15]	t _{HZ}	Chip Disable to Output Inactive		8		10		15	ns
t _{LZOE} ^[12, 15]	t _{OLZ}	Output Enable to Output Active	0		0		0		ns
t _{HZOE} [12, 15]	t _{OHZ}	Output Disable to Output Inactive		8		10		15	ns
t _{PU} ^[12]	t _{PA}	Chip Enable to Power Active	0		0		0		ns
t _{PD} ^[12]	t _{PS}	Chip Disable to Power Standby		20		25		45	ns
t _{DBE}	-	Byte Enable to Data Valid		10		12		20	ns
t _{LZBE} ^[12]	-	Byte Enable to Output Active	0		0		0		ns
t _{HZBE} ^[12]	-	Byte Disable to Output Inactive		8		10		15	ns
SRAM Write Cyc	cle	· · · ·						•	
t _{WC}	t _{WC}	Write Cycle Time	20		25		45		ns
t _{PWE}	t _{WP}	Write Pulse Width	15		20		30		ns
t _{SCE}	t _{CW}	Chip Enable To End of Write	15		20		30		ns
t _{SD}	t _{DW}	Data Setup to End of Write	8		10		15		ns
t _{HD}	t _{DH}	Data Hold After End of Write	0		0		0		ns
t _{AW}	t _{AW}	Address Setup to End of Write	15		20		30		ns
t _{SA}	t _{AS}	Address Setup to Start of Write	0		0		0		ns
t _{HA}	t _{WR}	Address Hold After End of Write	0		0		0		ns
t _{HZWE} [12, 15,16]	t _{WZ}	Write Enable to Output Disable		8		10		15	ns
t _{LZWE} [12, 15]	t _{OW}	Output Active after End of Write	3		3		3		ns
t _{BW}	-	Byte Enable to End of Write	15		20		30		ns

Switching Waveforms





Notes

13. WE must be HIGH during SRAM read cycles.
14. Device is continuously selected with CE, OE and BHE / BLE LOW.
15. Measured ±200 mV from steady state output voltage.
16. If WE is LOW when CE goes LOW, the outputs remain in the high impedance state.
17. HSB must remain HIGH during read and write cycles.

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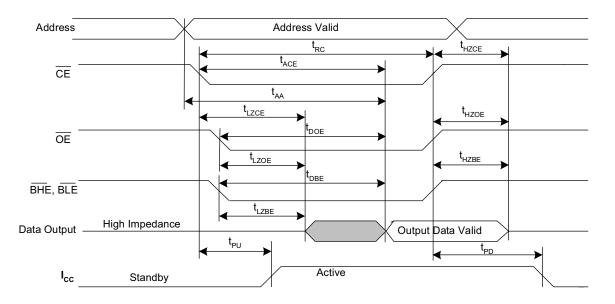
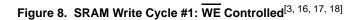
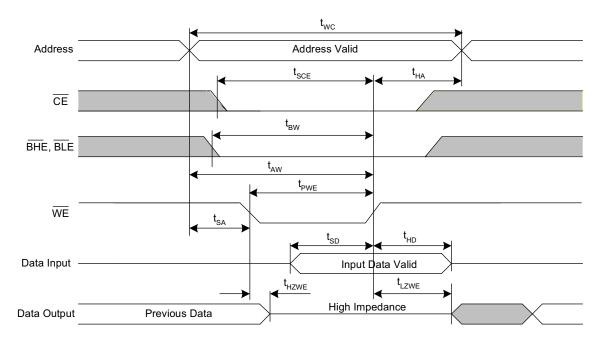


Figure 7. SRAM Read Cycle #2: \overline{CE} and \overline{OE} Controlled^[3, 13, 17]





Note 18. CE or WE must be $\geq V_{IH}$ during address transitions.



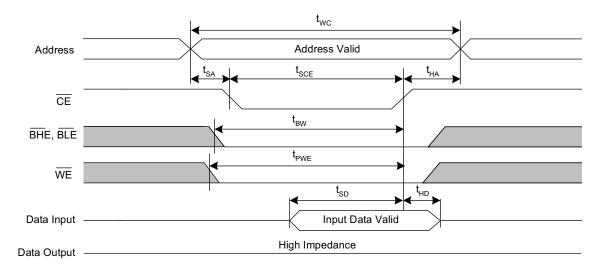
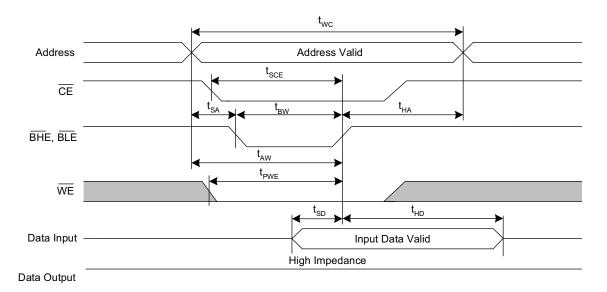


Figure 9. SRAM Write Cycle #2: CE Controlled^[3, 16, 17, 18]







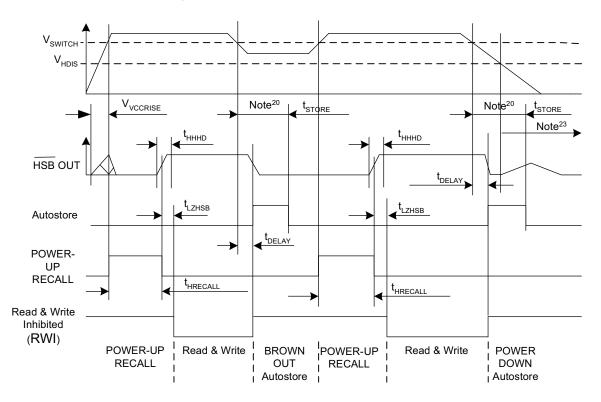


AutoStore/Power Up RECALL

Parameters	Description	20 ns		25 ns		45 ns		Unit
Farameters	Description	Min	Max	Min	Max	Min	Max	Unit
	Power Up RECALL Duration		20		20		20	ms
OTORE	STORE Cycle Duration		8		8		8	ms
t _{DELAY} ^[21]	Time Allowed to Complete SRAM Cycle		20		25		25	ns
V _{SWITCH}	Low Voltage Trigger Level		2.65		2.65		2.65	V
t _{VCCRISE}	VCC Rise Time	150		150		150		μS
V _{HDIS} ^[12]	HSB Output Driver Disable Voltage		1.9		1.9		1.9	V
t _{LZHSB}	HSB To Output Active Time		5		5		5	μS
t _{HHHD}	HSB High Active Time		500		500		500	ns

Switching Waveforms





Notes

19. t_{HRECALL} starts from the time V_{CC} rises above V_{SWITCH}.

20. If an SRAM write has not taken place since the last nonvolatile cycle, no AutoStore or Hardware Store takes place.

21. On a Hardware STORE, Software Store / Recall, AutoStore Enable / Disable and AutoStore initiation, SRAM operation continues to be enabled for time t_{DELAY}.

22. Read and write cycles are ignored during STORE, RECALL, and while VCC is below V_{SWITCH}.

23. HSB pin is driven HIGH to VCC only by internal 100 kOhm resistor, HSB driver is disabled.



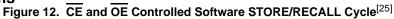


Software Controlled STORE/RECALL Cycle

In the following table, the software controlled STORE and RECALL cycle parameters are listed.^[24, 25]

Parameters	Description	20 ns		25 ns		45 ns		Unit	
Farameters	Description	Min	Max	Min	Max	Min	Max	Unit	
t _{RC}	STORE/RECALL Initiation Cycle Time	20		25		45		ns	
t _{SA}	Address Setup Time	0		0		0		ns	
t _{CW}	Clock Pulse Width	15		20		30		ns	
t _{HA}	Address Hold Time	0		0		0		ns	
t _{RECALL}	RECALL Duration		200		200		200	μS	

Switching Waveforms



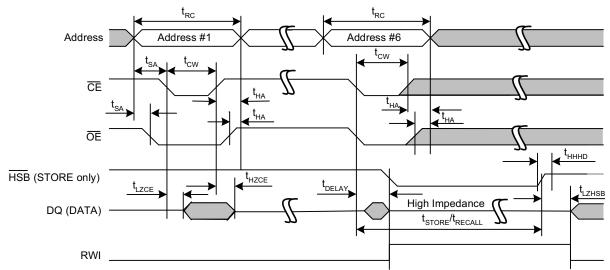
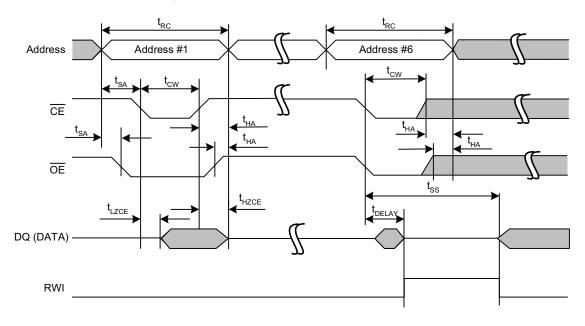


Figure 13. AutoStore Enable/Disable Cycle



Notes

24. The software sequence is clocked with \overline{CE} controlled or \overline{OE} controlled reads.

25. The six consecutive addresses must be read in the order listed in Table 1 on page 5. WE must be HIGH during all six consecutive cycles.

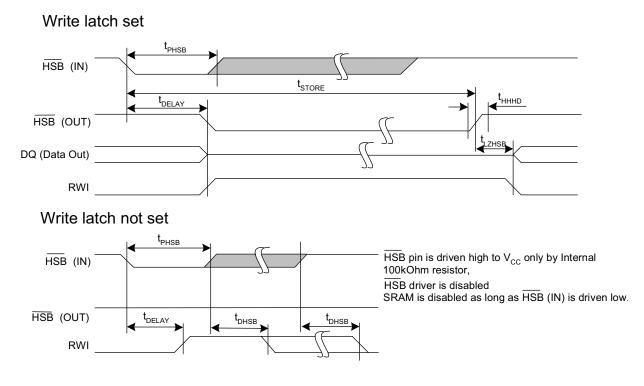


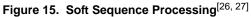
Hardware STORE Cycle

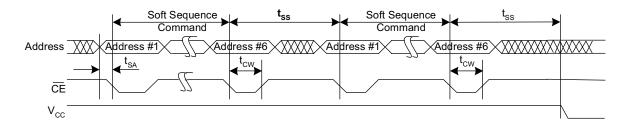
Parameters	Description	20 ns		25 ns		45 ns		Unit
Falameters	Description	Min	Max	Min	Max	Min	Max	Unit
t _{DHSB}	HSB To Output Active Time when write latch not set		20		25		25	ns
t _{PHSB}	Hardware STORE Pulse Width	15		15		15		ns
t _{SS} ^[26, 27]	Soft Sequence Processing Time		100		100		100	μS

Switching Waveforms









Notes

26. This is the amount of time it takes to take action on a soft sequence command. Vcc power must remain HIGH to effectively register command. 27. Commands such as STORE and RECALL lock out I/O until operation is complete which further increases this time. See the specific command.



Truth Table For SRAM Operations

HSB should remain HIGH for SRAM Operations.

For x8 Configuration

CE	WE	OE	Inputs/Outputs ^[2]	Mode	Power
Н	Х	Х	High Z	Deselect/Power down	Standby
L	Н	L	Data Out (DQ ₀ –DQ ₇);	Read	Active
L	Н	Н	High Z	Output Disabled	Active
L	L	Х	Data in (DQ ₀ –DQ ₇);	Write	Active

For x16 Configuration

CE	WE	OE	BHE ^[3]	BLE ^[3]	Inputs/Outputs ^[2]	Mode	Power
Н	Х	Х	Х	Х	High-Z	Deselect/Power down	Standby
L	Х	Х	Н	Н	High-Z	Output Disabled	Active
L	Н	L	L	L	Data Out (DQ ₀ –DQ ₁₅)	Read	Active
L	Н	L	Н	L	Data Out (DQ ₀ –DQ ₇); DQ ₈ –DQ ₁₅ in High-Z	Read	Active
L	Н	L	L	Н	Data Out (DQ ₈ –DQ ₁₅); DQ ₀ –DQ ₇ in High-Z	Read	Active
L	Н	Н	L	L	High-Z	Output Disabled	Active
L	Н	Н	Н	L	High-Z	Output Disabled	Active
L	Н	Н	L	Н	High-Z	Output Disabled	Active
L	L	Х	L	L	Data In (DQ ₀ –DQ ₁₅)	Write	Active
L	L	Х	Н	L	Data In (DQ ₀ –DQ ₇); DQ ₈ –DQ ₁₅ in High-Z	Write	Active
L	L	Х	L	Н	Data In (DQ ₈ –DQ ₁₅); DQ ₀ –DQ ₇ in High-Z	Write	Active



Ordering Information

Speed (ns)	Ordering Code	Package Diagram	Package Type	Operating Range	
20	CY14B104LA-ZS20XCT	51-85087	44-pin TSOP II	Commercial	
	CY14B104LA-ZS20XC	51-85087	44-pin TSOP II		
	CY14B104LA-ZS20XIT	51-85087	44-pin TSOP II	Industrial	
	CY14B104LA-ZS20XI	51-85087	44-pin TSOP II		
	CY14B104LA-BA20XCT	51-85128	48-ball FBGA	Commercial	
	CY14B104LA-BA20XC	51-85128	48-ball FBGA		
	CY14B104LA-BA20XIT	51-85128	48-ball FBGA	Industrial	
	CY14B104LA-BA20XI	51-85128	48-ball FBGA		
	CY14B104NA-ZS20XCT	51-85087	44-pin TSOP II	Commercial	
	CY14B104NA-ZS20XC	51-85087	44-pin TSOP II		
	CY14B104NA-ZS20XIT	51-85087	44-pin TSOP II	Industrial	
	CY14B104NA-ZS20XI	51-85087	44-pin TSOP II		
	CY14B104NA-BA20XCT	51-85128	48-ball FBGA	Commercial	
	CY14B104NA-BA20XC	51-85128	48-ball FBGA		
	CY14B104NA-BA20XIT	51-85128	48-ball FBGA	Industrial	
	CY14B104NA-BA20XI	51-85128	48-ball FBGA		
	CY14B104NA-ZSP20XCT	51-85160	54-pin TSOP II	Commercial	
	CY14B104NA-ZSP20XC	51-85160	54-pin TSOP II		
	CY14B104NA-ZSP20XIT	51-85160	54-pin TSOP II	Industrial	
	CY14B104NA-ZSP20XI	51-85160	54-pin TSOP II		
25	CY14B104LA-ZS25XCT	51-85087	44-pin TSOP II	Commercial	
	CY14B104LA-ZS25XC	51-85087	44-pin TSOP II		
	CY14B104LA-ZS25XIT	51-85087	44-pin TSOP II	Industrial	
	CY14B104LA-ZS25XI	51-85087	44-pin TSOP II		
	CY14B104LA-BA25XCT	51-85128	48-ball FBGA	Commercial	
	CY14B104LA-BA25XC	51-85128	48-ball FBGA		
	CY14B104LA-BA25XIT	51-85128	48-ball FBGA	Industrial	
	CY14B104LA-BA25XI	51-85128	48-ball FBGA		
	CY14B104NA-ZS25XCT	51-85087	44-pin TSOP II	Commercial	
	CY14B104NA-ZS25XC	51-85087	44-pin TSOP II		
	CY14B104NA-ZS25XIT	51-85087	44-pin TSOP II	Industrial	
	CY14B104NA-ZS25XI	51-85087	44-pin TSOP II		
	CY14B104NA-BA25XCT	51-85128	48-ball FBGA	Commercial	
	CY14B104NA-BA25XC	51-85128	48-ball FBGA		
	CY14B104NA-BA25XIT	51-85128	48-ball FBGA	Industrial	
	CY14B104NA-BA25XI 51-85128		48-ball FBGA		
	CY14B104NA-BA25I	51-85128	48-ball FBGA		
	CY14B104NA-ZSP25XCT	51-85160	54-pin TSOP II	Commercial	
	CY14B104NA-ZSP25XC	51-85160	54-pin TSOP II		
	CY14B104NA-ZSP25XIT	51-85160	54-pin TSOP II	Industrial	
	CY14B104NA-ZSP25XI	51-85160	54-pin TSOP II		





Ordering Information (continued)

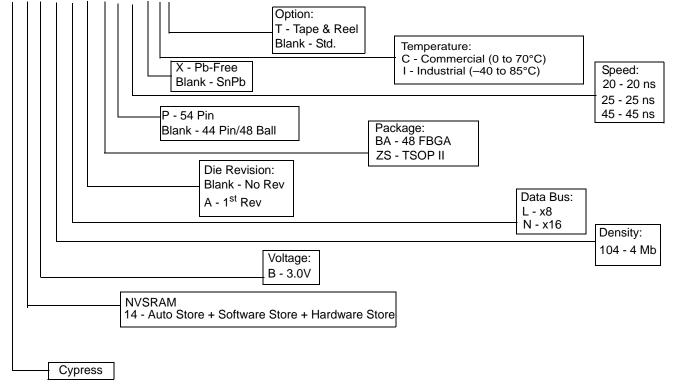
Speed (ns)	Ordering Code	Package Diagram	Package Type	Operating Range
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	CY14B104LA-ZS45XC	51-85087	44-pin TSOP II	
	CY14B104LA-ZS45XIT	51-85087	44-pin TSOP II	Industrial
	CY14B104LA-ZS45XI	51-85087	44-pin TSOP II	
	CY14B104LA-BA45XCT	51-85128	48-ball FBGA	Commercial
	CY14B104LA-BA45XC	51-85128	48-ball FBGA	
	CY14B104LA-BA45XIT	51-85128	48-ball FBGA	Industrial
	CY14B104LA-BA45XI	51-85128	48-ball FBGA	
	CY14B104NA-ZS45XCT	51-85087	44-pin TSOP II	Commercial
	CY14B104NA-ZS45XC	51-85087	44-pin TSOP II	
	CY14B104NA-ZS45XIT	51-85087	44-pin TSOP II	Industrial
	CY14B104NA-ZS45XI	51-85087	44-pin TSOP II	
	CY14B104NA-BA45XCT	51-85128	48-ball FBGA	Commercial
	CY14B104NA-BA45XC	51-85128	48-ball FBGA	
	CY14B104NA-BA45XIT	51-85128	48-ball FBGA	Industrial
	CY14B104NA-BA45XI	51-85128	48-ball FBGA	
	CY14B104NA-ZSP45XCT	51-85160	54-pin TSOP II	Commercial
	CY14B104NA-ZSP45XC	51-85160	54-pin TSOP II	
	CY14B104NA-ZSP45XIT	51-85160	54-pin TSOP II	Industrial
	CY14B104NA-ZSP45XI	51-85160	54-pin TSOP II	

The above table contains Preliminary information. Contact your local Cypress sales representative for availability of these parts.



Part Numbering Nomenclature

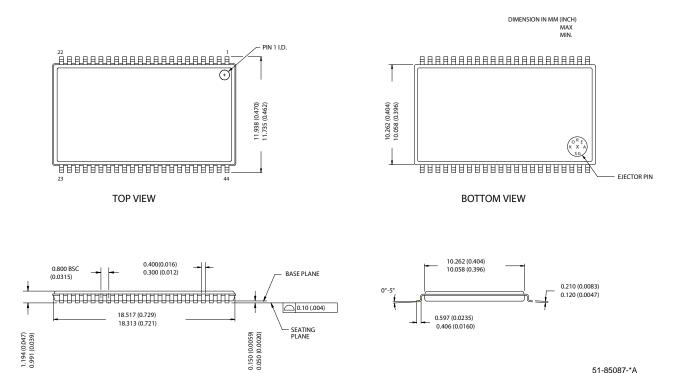






Package Diagrams

Figure 16. 44-Pin TSOP II (51-85087)



51-85087-*A



А

В

с

D

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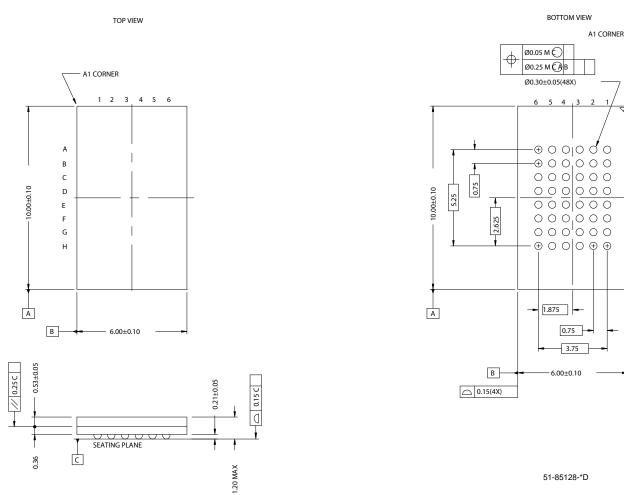
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Package Diagrams (continued)

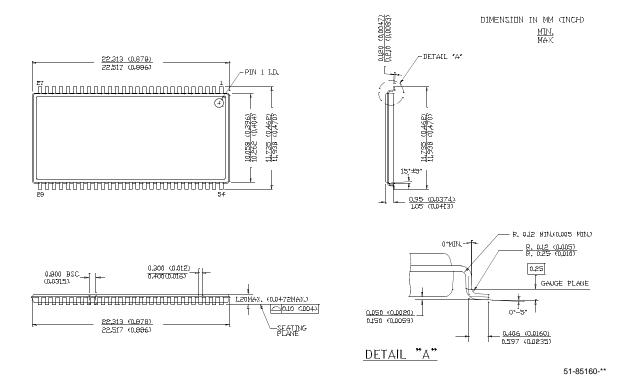






Package Diagrams (continued)

Figure 18. 54-Pin TSOP II (51-85160)





Document History Page

Document Title: CY14B104LA/CY14B104NA 4 Mbit (512K x 8/256K x 16) nvSRAM Document Number: 001-49918							
Rev. ECN No. Orig. of Change Submission Date Description of Change		Description of Change					
**	2606696	GVCH/PYRS	11/13/08	New Data Sheet			
*A	2672700	GVCH/PYRS	03/12/09	Added best practices Added CY14B104NA-BA25I part number Added footnote12 for HZ/LZ parameters			

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